

CUSTOMER:	 DATE:	

# APPROVAL SPECIFICATION



PRODUCT NAME:	SMD power inductor	
YOUR PART NO.:		ζ,
OUR PART NO. :	MPIA201610 Series	
VERSION: V2.0		30

RECEPTION	A.			
THE SPECIFICAT	TION HAS BEEN ACCEP	TED.		
COMPANY:				
CFMD	CHKD	RCVD		

MANUFACTURING NAME

SHENZHEN MICROGATE TECHNOLOGY CO., LTD

Address: Microgate Smart Park, Technology Road, Zhukeng Community, Longtian Street, Pingshan District, Shenzhen.

Postcode: 518122 TEL: 86-755-28085000 FAX: 86-755-28085605

CFMD.	CHKD.	DSGD.
Charles	Wang Yusheng	Liu Wei



### **CATALOG**

	Component SPEC Version Record.	3
1	Scope	
2	Product Identification	4
3	Appearance, Dimensions and Material	4
4	Testing Conditions	5
5	Electrical Characteristics And Test Instruments	5
6	Reliability	
7	Recommended Soldering Conditions	8
8	Package Information	9
9	Visual inspection standard of product	10
10	Products Storage.	10



#### **Component SPEC Version Record**

Rev.	Effective Date	Changed Contents	Change Reasons	Approved By
1.0	Dec. 10.2012	New released	/	Charles
2.0	JUL. 31.2014	Change the Electrical Characteristics	The Electrical Characteristics improved	Charles



#### 1. Scope

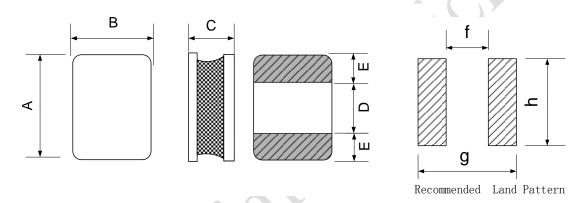
This specification applies to the MPIA201610 series of SMD power inductor.

#### 2. Product Identification

- ① Product Symbol (A type SMD power inductor)
- ② Product dimensions (2.0×1.6×1.0mm)
- ③ Inductance Value: (R68:0.68 uH; 2R2: 2.2uH;100:10uH; 101:100uH)
- ④ Inductance Tolerance: (M: ±20%; N: ±30%)
- © Lead free product.

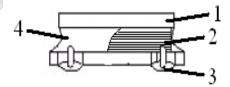
#### 3. Appearance, Dimensions and Material

#### 3.1 Appearance and dimensions



	Dimensions in mm						
A	В	C	D	Е	f	g	h
2.00±0.20	1.60±0.20	1.00Max.	0.70±0.2	0.65±0.2	0.80 Тур.	2.20 Тур.	1.60 Typ.

#### 3.2 Material List



No.	Item	Material
1	Core	Mixed Alloy Material
2	Wire	Enameled Copper Wire
3	Terminal Electrode	Ag/Ni/Sn/Cu
4	Magnetic Glue	Epoxy resin and magnetic powder



#### **4.Testing Conditions**

Unless otherwise specified, the standard conditions for measurement/test as:

Ambient Temperature : 5 to 35 °C Relative Humidity: 25 to 85% RH Atmospheric Pressure: 86 to 106 kPa

If any doubt on the results, measurements/tests should be made within the following limits:

Ambient Temperature : 25±1 °C Relative Humidity: 60 to 70% RH Atmospheric Pressure: 86 to 106 kPa

#### **5. Electrical Characteristics And Test Instruments**

Microgate Part No.	Inductance L (uH)	DCF	DCR(Ω)		Isat*1 (A)		Irms <sup>•2</sup> (A)	
wheregate rare wo.	1MHz/1V	Max.	Тур.	Max.	Тур.	Max.	Тур.	
MPIA201610-R24M-LF	0.24±20%	0.032	0.028	5.00	5.50	3.65	4.30	
MPIA201610-R33M-LF	0.33±20%	0.032	0.028	4.00	4.60	4.00	4.80	
MPIA201610-R47M-LF	0.47±20%	0.035	0.029	3.50	4.00	3.80	4.50	
MPIA201610-R68M-LF	0.68±20%	0.057	0.048	3.00	3.40	2.60	3.00	
MPIA201610-1R0M-LF	1.0±20%	0.090	0.075	2.70	3.15	2.10	2.40	
MPIA201610-1R5M-LF	1.5±20%	0.130	0.110	2.00	2.20	1.70	2.00	
MPIA201610-2R2M-LF	2.2±20%	0.165	0.138	1.75	2.10	1.25	1.45	
MPIA201610-4R7M-LF	4.7±20%	0.430	0.375	1.00	1.30	0.90	1.00	

#### **Test instruments and remarks**

- \* All test data is referenced to 25°C ambient.
- \* L test by CHROMA 3302 meter or equivalent.
- \* DCR test by Tonghui TH2516B meter or equivalent.
- \* CHROMA 3302 and 1320 meter for IDC.
- \* Isat: DC current (A) that will cause L0 to drop approximately 30%.
- \* Irms: DC current (A) that will cause an temperature rise  $\triangle$  T approximate to 40°C.
- \* The rated current as listed is either the saturation current or the heating current depending on which value is lower.
- \* Operating temperature:  $-40^{\circ}$ C to  $+125^{\circ}$ C (Including self-heating)
- \* The part temperature (ambient + temp rise) should not exceed 125°C under worse case operating conditions. Circuit design, component placement, PCB trace size and thickness, airflow and other cooling provision all affect the part temperature. Part temperature should be verified in the end application.
- \* Maximum rated voltage :DC 20 V



## 6. Reliability

No.	Item	Requirements	Test Methods and Remarks	Reference	Sample Size
1	Solderability	<ul><li>(1) No physical damage.</li><li>(2) Terminal area must have 95% min. solder coverage.</li></ul>	①Temperature:245±5°C, flux 5-10 s. ②Sample immersion tin furnace 5±0.5s. ③Immersed and in and out of speed: 25 ±6mm/s.	AEC-Q200 (J-STD-002)	15
2	Resistance to Soldering Heat		① The peak temperature: 260+5/-0°C. ② Reflow:3times. ③ Temperature curve is as below:  Peak 265°C  Max. Ramp Up Rate=3°C/s  Max. Ramp Down Rate=-6°C/s  150°C  150°C  Max. Ramp Down Rate=-6°C/s  Time 25°C to Peak =8 min  Time	AEC-Q200 (MIL-STD-20 2 Method 210)	30
3	High Temperature Storage	(1) No physical	①Temperature: 125±2°C. ②Time: 1000 hours. ③Measurement at 24±4 hours after test conclusion.  Temperature 125°C Room Temp.  0 1000H Time	AEC-Q200 (MIL-STD -202 Method 108)	77
4	Low Temperature Storage	damage. (2)   ΔL0/L0   ≤10%	①Temperature: -55±2°C. ②Time: 1000 hours. ③Measurement at 24±4 hours after test conclusion.  Room Temp.  1000H  Time  Low temperature 24H  Temp.	JESD22-A119	77
5	Thermal shock		①First -40°C for 15 minutes, last 125°C 15minutes as 1 cycle. Go through 300 cycles. ②Max transfer time is 20 second. ③Measurement at 24±4 hours after test conclusion.  125°C 15 min. 15 min.  Ambient 15 min. 15 min. 20 s (max.)	MIL-STD -202 Method 107	30



No.	Item	Requirements	Test Methods and Remarks	Reference	Sample Size
6	Humidity Resistance		①1000 hours, 85 °C/85% RH. ②Unpowered. ③Measurement at 24 ±4 hours after test conclusion.  High temperature High humidity  85 °C  Room Temp.  24H  1000H Time	AEC-Q200 (MIL-STD -202 Method 103)	77
7	Terminal Strength		①The test samples shall be soldered to the board. ②17.64N, 60s.  Radius 0.5mm  DUT  Press tools Shear Force	AEC-Q200 (AEC-Q200-0 06)	30
8	Board Flex	<ul> <li>(1) No physical damage.</li> <li>(2)   ΔL0/L0   ≤10%</li> </ul>	①Part mounted on a 100mm*40mm FR4 PCB board, which is 1.6±0.2 mm thick and as a Layer-thickness 35 µm ±10 µm. ②Bending speed is 1mm/s. ③Keeping the P.C Board 2 mm minimum for 60 seconds.  Support  Solder Chip Printed circuit board before testing 45±2  Printed circuit board under test  Unit: mm	AEC-Q200 (AEC-Q200-0 05)	30
9	Drop		①Height: 1 m, Free fall, 10times. ②Direction: 1 Angle, 1side, 2surface.	JESD22-B111	30
10	Vibration		①Frequency range: 10~2000Hz. ②Amplitude: 1.5mm, 5g. ③Sweep time and duration: 10~2000~10Hz for 20 minutes. ④Each four hours(12 times) in X,Y,Z direction, 12 hours in total.	AEC-Q200 (MIL-STD-20 2 Method 204)	30

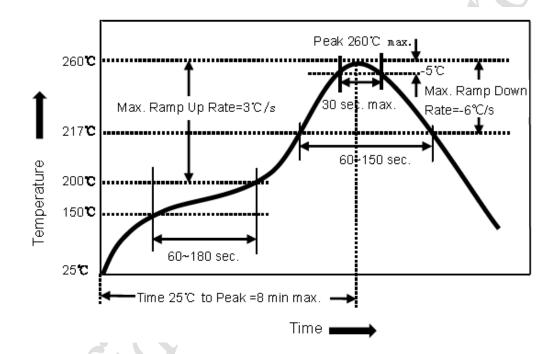


No.	Item	Requirements	Test Methods and Remarks	Reference	Sample Size
11	Loading at High Temperature	<ul> <li>(1) No physical damage.</li> <li>(2)   ΔL0/L0   ≤10%</li> </ul>	①Temperature: 85 ±2 °C. ②Time: 1000 hours. ③Applied Current: Rated current. ④Measurement at 24 ±4 hours after test conclusion.	AEC-Q200 (MIL-PRF-27)	77

<sup>\*</sup>All above experiments items need 3 Lot., sample size is as specified in the table above.

#### 7. Recommended Soldering Conditions

#### (1) Reflow soldering conditions



<sup>\*</sup>Above reflow soldering curve is from J-STD-020D.

#### (2) Iron soldering

The following conditions must be strictly followed when using a soldering iron.

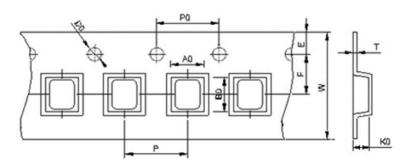
Pre-heating	150°C 1 minute
Tip temperature	350℃ max
Soldering iron output	30w max
End of soldering iron	Ф1mm max
Soldering time	3 seconds max

<sup>\*</sup>Sample size standard is from AEC-Q200: qualification sample size requirements.



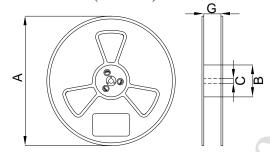
#### 8. Package Information

#### (1) Dimension of tape (Unit: mm)



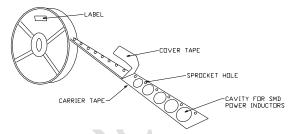
W	A0	В0	K0	Е	F	P	P0	D0	Т
8.0±0.3	1.90±0.1	2.30±0.10	1.20±0.1	1.75±0.1	3.5±0.05	4.0±0.1	4.0±0.1	1.5+0.1/-0.0	0.18±0.03

(2) Dimension of reel (Unit: mm)



Symbol (	Dimension		
A	178±2		
В	58±2		
С	$13.5 \pm 0.2$		
G	$9.0 \pm 0.5$		

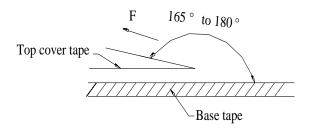
#### (3) Taping figure and drawing direction



(4) Packaging quantities: 2000PCS/Reel.

#### (5) Peeling strength of cover tape:

The peel force of top cover tape shall be between 0.10N to 1.0N \*the peel force standard is from EIA-481-D



Room Temp. Room Humidity $(^{\circ}C)$ $(\%)$		Room aim (hpa)	Peel Speed mm/min
5-35	45-85	860-1060	300

Add: Microgate Smart Park, Technology Road, Zhukeng Community, Longtian Street, Pingshan District, Shenzhen.

Tel: +86-755-28085000 Fax: +86-755-28085605 Postcode: 518122 9/10



#### 9. Visual inspection standard of product

No.	Defect Item	Graphic	Rejection identification	Acceptance
1	Core defect	W	1 >L/6 or w >W/6, NG.	AQL=0.65
2	Missing resin		The area of missing resin more than single face, NG	AQL=0.65
3	Cold solder	- <u>L</u> -	L more than 1 mm, NG.	AQL=0.65
4	Solder uneven	H	H>0.1mm. NG.	AQL=0.65

#### 10. Products Storage

#### (1) Storage period

Products which inspected in MICROGATE over 12 months ago should be examined and used, which can be confirmed with inspection No. marked on the container. Solderability should be checked if this period is exceeded.

#### (2) Storage conditions

Products should be storage in the warehouse on the following conditions:

Temperature: -10 ~+ 35 °C

Humidity: Less than 70% relative and humidity

No rapid change on temperature and humidity.

- (3) Don't keep products in corrosive gases such as sulfur, chlorine gas or acid, or it may cause oxidization of electrode, resulting in poor solderability.
- (4) Products should be storage on the palette for the prevention of the influence from humidity, dust and so
- (5) Products should be storage in the warehouse without heat shock, vibration, direct sunlight and so on.
- (6) Products should be storage under the airtight packaged condition.